

AD-A173 471

DYNAMICAL HOLE-BURNING REQUIREMENTS FOR FREQUENCY
DOMAIN OPTICAL STORAGE(U) IBM ALMADEN RESEARCH CENTER
SAN JOSE CA W E MOERNER 29 JAN 86 TR-6

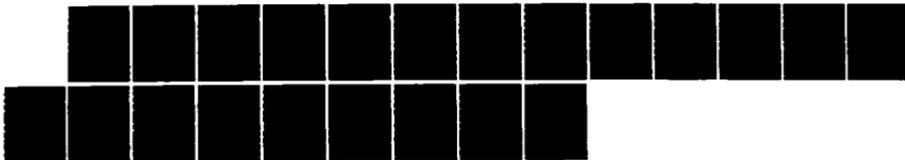
1/1

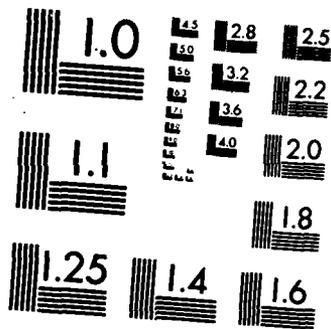
UNCLASSIFIED

N00014-84-C-0700

F/G 14/3

NL





MICROCOPY RESOLUTION TEST CHART
NATIONAL BUREAU OF STANDARDS-1963-A

12

AD-A173 471

REPORT DOCUMENTATION PAGE

		1b. RESTRICTIVE MARKINGS	
2b. DECLASSIFICATION / DOWNGRADING SCHEDULE		3. DISTRIBUTION / AVAILABILITY OF REPORT This document has been approved for public release and sale; its distribution is unlimited.	
4. PERFORMING ORGANIZATION REPORT NUMBER(S) Technical Report No. 6, IBM RJ 5019		5. MONITORING ORGANIZATION REPORT NUMBER(S)	
6a. NAME OF PERFORMING ORGANIZATION IBM Almaden Research Center	6b. OFFICE SYMBOL (If applicable)	7a. NAME OF MONITORING ORGANIZATION Office of Naval Research Chemistry Division, Code 1113	
6c. ADDRESS (City, State, and ZIP Code) 650 Harry Road San Jose, CA 95120-6099		7b. ADDRESS (City, State, and ZIP Code) Arlington, VA 22217 OCT 13 1986	
8a. NAME OF FUNDING / SPONSORING ORGANIZATION	8b. OFFICE SYMBOL (If applicable)	9. PROCUREMENT INSTRUMENT IDENTIFICATION NUMBER N00014-84-C-0708	
8c. ADDRESS (City, State, and ZIP Code)		10. SOURCE OF FUNDING NUMBERS	
		PROGRAM ELEMENT NO.	PROJECT NO.
		TASK NO.	WORK UNIT ACCESSION NO.
11. TITLE (Include Security Classification) Dynamic Hole-Burning Requirements for Frequency Domain Optical Storage			
12. PERSONAL AUTHOR(S) W. E. Moerner			
13a. TYPE OF REPORT Interim Technical	13b. TIME COVERED FROM TO	14. DATE OF REPORT (Year, Month, Day) January 29, 1986	15. PAGE COUNT 16
16. SUPPLEMENTARY NOTATION Proceedings of the Second International Conference on Unconventional Photoactive Solids, Plenum Press			
17. COSATI CODES		18. SUBJECT TERMS (Continue on reverse if necessary and identify by block number)	
FIELD	GROUP	SUB-GROUP	
		Persistent spectral hole-burning, frequency domain optical storage, photon gating, biphotonic, nondestructive reading.	
19. ABSTRACT (Continue on reverse if necessary and identify by block number) Persistent spectral hole-burning (PHB) is a frequency-selective bleaching phenomenon that potentially provides a new dimension for optical storage of information, if suitable materials can be found. In the most general form of PHB, narrow depressions or "holes" are formed ("burned") in an inhomogeneously broadened absorption line of an absorber in a solid at low temperatures whenever light absorption causes a change in the absorbing center that persists longer than any excited state lifetime. Previously studied materials involve monophotonic mechanisms for the photochemical or photophysical change leading to hole formation; such mechanisms have serious limitations as to the number of reads that can be performed without distortion of the written data. Recently, photon gated spectral hole-burning has been observed in both inorganic and organic materials, indicating that nondestructive reading of spectral holes is possible. This talk will focus on the properties of the organic photon gated material in particular and describe the properties of what might be termed an "ideal" photon-gated system.			
20. DISTRIBUTION / AVAILABILITY OF ABSTRACT <input checked="" type="checkbox"/> UNCLASSIFIED/UNLIMITED <input type="checkbox"/> SAME AS RPT <input type="checkbox"/> DTIC USERS		21. ABSTRACT SECURITY CLASSIFICATION Unclassified	
22a. NAME OF RESPONSIBLE INDIVIDUAL		22b. TELEPHONE (Include Area Code)	22c. OFFICE SYMBOL

DTIC FILE COPY

OFFICE OF NAVAL RESEARCH

Contract N00014-84-C-0708

R&T Code 413a001---01

Technical Report No. 6

Dynamical Hole-Burning Requirements for
Frequency Domain Optical Storage

by

W. E. Moerner

Prepared for Publication

in

Proceedings of the Second International Conference on
Unconventional Photoactive Solids, Plenum Press

IBM Almaden Research Center
650 Harry Road
San Jose, California 95120-6099

January 29, 1986

Reproduction in whole, or in part, is permitted for any purpose of the United States Government.

* This document has been approved for public release and sale; its distribution is unlimited.

RJ 5019 (52269) 1/29/86
Solid State Physics

**DYNAMICAL HOLE-BURNING REQUIREMENTS FOR FREQUENCY
DOMAIN OPTICAL STORAGE**

W. E. Moerner

IBM Almaden Research Center
K32/802D, 650 Harry Road
San Jose, California 95120-6099

ABSTRACT: Persistent spectral hole-burning (PHB) is a frequency-selective bleaching phenomenon that potentially provides a new dimension for optical storage of information, if suitable materials can be found. In the most general form of PHB, narrow depressions or "holes" are formed ("burned") in an inhomogeneously broadened absorption line of an absorber in a solid at low temperatures whenever light absorption causes a change in the absorbing center that persists longer than any excited state lifetime. Previously studied materials involved monophotonic mechanisms for the photochemical or photophysical change leading to hole formation; such mechanisms have serious limitations as to the number of reads that can be performed without distortion of the written data. Recently, photon gated spectral hole-burning has been observed in both inorganic and organic materials, indicating that nondestructive reading of spectral holes is possible. This talk will focus on the properties of the organic photon gated material in particular and describe the properties of what might be termed an "ideal" photon-gated system.

Accession For 



Handwritten initials

Dynamical Hole-Burning Requirements for Frequency Domain Optical Storage

W. E. Moerner

IBM Almaden Research Center
K32/802D, 650 Harry Road
San Jose, CA 95120

INTRODUCTION

One potentially important application of laser spectroscopy and photochemistry of molecular and ionic defects in solids at low temperatures is the use of persistent spectral hole-burning to form a frequency domain optical storage system [1] [2] [3] [4] [5]. PHB (also called photochemical hole-burning although photophysical hole-burning also occurs) has the interesting property of allowing as many as 1000 or more bits of information to be stored in the volume irradiated by a single focused laser beam. PHB utilizes an additional dimension beyond x-y spatial dimensions to achieve this dramatic increase in areal storage density. In effect, various bits are addressed by the laser frequency or wavelength at which they are stored, hence the name "frequency domain optical storage." means the use of PHB for optical storage of digital data. Of course, the feasibility of such a data storage scheme depends critically upon having recording materials that undergo spectral hole-burning with certain well-defined dynamical characteristics. It is a stimulating and interdisciplinary challenge for the solid-state spectroscopist, photochemist, and laser physicist to find suitable mechanisms and to devise detection techniques that make this application possible.

The first requirement for spectral hole-burning is that the guest molecules (or other absorbing centers[6]) must be dispersed in a suitable transparent matrix and cooled to liquid helium temperatures. The molecules must be sufficiently rigid and sufficiently uncoupled from the host lattice that the lowest energy optical absorption (the "zero-phonon" absorption or the purely electronic transition) has appreciable oscillator strength. This requirement simply means that the Franck-Condon distortion in the electronic excited state cannot be too large. If the host matrix were a perfect crystal, the zero-phonon line would appear as in the upper half of Figure 1: all molecules would absorb at the same frequency with the same width, Γ_H , called the homogeneous width of the electronic origin. However, in a real crystal, glass, or polymer (see the lower half of Figure 1), slight differences in the environment around each molecule caused by local strains or nearby defects cause the various molecules absorb at slightly different wavelengths. For this case, the way in which the sample absorbs light in the lowest energy absorption can be viewed as a superposition of narrow absorption lines of width Γ_H from the various molecules distributed throughout the sample. The result is a broad, smooth absorption line of width Γ_I that is said to be inhomogeneously broadened.

THE BASIC PROCESS OF SPECTRAL HOLE FORMATION

If a laser beam with a well-defined frequency ω_1 irradiates such a sample, only those molecules that are in resonance with the laser can be excited (see Figure 2 (a) and (b)).

If the laser linewidth is less than Γ_I or better yet less than Γ_H as is usually the case, one can selectively excite different classes of molecules simply by tuning the laser. The number of different classes of molecules that can be accessed in this way is on the order of the ratio of the inhomogeneous width to the homogeneous width, Γ_I/Γ_H , a factor which can range from 100 to 10^4 . (It is precisely because we want this factor to be large that liquid helium temperatures are required. At higher temperatures, Γ_H becomes larger than Γ_I due to phonon scattering and other temperature-dependent dephasing effects.) If the laser is focused to a small spot, the size of that spot is limited by the wavelength of the light itself to be greater than roughly one micron in diameter. Even within the small volume irradiated by a one micron diameter laser beam, a narrowband tunable laser can easily probe different groups of molecules simply by changing the laser wavelength.

Now if the molecules undergo a photo-induced change when light is absorbed (see Figure 2(b)) such that the product does not absorb at the laser wavelength, the optical absorption at ω_1 decreases. Such light-induced changes may involve a photochemical change in the molecule itself where a product is formed [8] [9] or a light-induced change in the local environment near the molecule [10] [11]. The resulting decrease or "dip" at ω_1 in the absorption line is called a spectral hole. If the photoinduced change in the molecule is persistent on time scales of months or years at low temperatures, the spectral holes at various locations within the line can be used to encode binary information, where, for instance, the presence of a hole at a particular frequency within the inhomogeneous line might correspond to a binary "1" and the absence of a hole might correspond to a binary "0". Figure 3 gives an example of a 19 bit hole pattern written in the absorption line of free-base phthalocyanine molecules in a poly(methylmethacrylate) (PMMA) host[4]. Since in one laser spot many groups of molecules are available, 1000 or perhaps 10,000 bits can, in principle, be stored in the frequency domain in the volume illuminated by a focused laser beam, resulting in potential areal storage densities as large as 10^{11} bits/cm². This type of data storage system can feature fast random access and high data rates as well as high areal density, and is called a frequency domain optical storage system. As one can see, PHB utilizes many of the unique properties of laser radiation: narrow linewidth, spatial coherence, and tunability. The ability to use PHB in a future optical storage application depends heavily upon the dynamics of the photo-induced change that occurs in the absorbing centers such as hole width, quantum efficiency, presence of bottlenecks, etc.

GENERAL SYSTEMS AND MATERIALS ISSUES

It is to be emphasized that even though the frequency domain optical storage concept sounds simple, this idea can hardly be regarded as a fully practical technology at the present time. Indeed, no single material has been found that possesses all the required properties. In the rest of this paper, several crucial materials and engineering issues and their partial solutions will be described. Table 1 lists some of the properties that are required of the reading and writing system engineering and Table 2 list some of the required materials properties in order to produce practical data storage and retrieval. The middle column lists the material or technique with which the property has been demonstrated. For each entry in the table, the reader is urged to consult the references for more detail. In general, most of the engineering or systems requirements have been shown to be solvable within the current state of the art, although single-mode diode lasers with wider tuning ranges would be desirable. In particular, recent research on FM spectroscopy has demonstrated the shot-noise-limited sensitivity of this method for detection of unmodulated absorptions[21].

Any reasonable system design also places demands on the dynamical properties of the photoactive hole-burning material itself, and Table 2 summarizes some of the principal requirements. Most of these requirements involve fairly obvious considerations. For instance, the material must undergo photochemistry at GaAlAs laser wavelengths, because these lasers are tunable, inexpensive, compact, and readily available commercially. To give

another example, holes must be burned in times on the order of 30 ns in order to handle the high data rates expected for a large data base. Recently, detectable holes have been burned in less than 100 nsec using a high sensitivity organic system and FM spectroscopy detection[27]. The existence of most of the required properties in the upper half of the table has been separately demonstrated in a number of inorganic and organic systems, which attests to the high rate of recent progress in this area.

SINGLE-PHOTON PROCESSES

Let us now focus on the entry in Table 2 that is third from the bottom: a material in order to be useful in a practical storage system must simultaneously show all the required properties: the ability to form deep holes in short burning times and yet allow fast reading at high signal-to-noise ratios with focused beams. This requirement places several well-defined constraints on the dynamical properties of the hole-burning mechanism. For example, a material with low hole-burning efficiency would be quite easy to read without serious destruction of the written holes, but such a system would be difficult to write with high contrast in short burning times. Conversely, a system that shows fast burning due to a high quantum efficiency for hole production would be difficult to read without burning of the unwritten centers by the tightly focused reading beam.

To understand this problem more fully, a thorough analysis of the coupled reading-writing problem in small spots for materials with monophotonic or single-photon hole-burning mechanisms has been recently completed[28]. Figure 4 schematically shows the energy level structure appropriate to single-photon mechanisms. An incident photon flux F is absorbed with an absorption cross section σ . A given center that has absorbed a photon can either decay to the ground state with rate Γ_1 or undergo the transformation leading to hole-burning with probability or quantum efficiency η [29]. This simple level diagram contains all the salient features of monophotonic photochemical processes. The essential problem with single-photon processes is that there is no threshold in the hole formation mechanism. The process of hole detection requires the absorption of photons by the remaining unburned centers, and if high powers are necessary to detect the dip in the absorption line with adequate signal-to-noise, the hole pattern will be destroyed by the reading laser beam (i.e., a "trench" will be formed over the spectral region probed by the reading laser). This optimization problem has been analyzed in detail to determine whether any combination of single-photon materials parameters would yield acceptable reading performance [28].

Figure 5 shows the results of this dynamical analysis of single-photon mechanisms. The two fundamental materials parameters are naturally the hole-burning quantum efficiency η and the low temperature peak absorption cross section σ . A material with specific values of η and σ would be represented by a point on the η - σ plane shown in the figure. Furthermore, since the analysis requires that the absorption coefficient α_0 of the sample be fixed at a constant value that optimizes the signal-to-noise ratio, the concentration of centers necessary to keep α_0 fixed (top axis) must decrease as the cross section increases. In other words, for given η and σ , the concentration listed on the top axis must be achieved in order to optimize the signal-to-noise ratio. The lower right triangular region represents the class of materials parameters that would not yield acceptable signal-to-noise ratios for any number of reads. In other words, a useful single-photon material must have low absorption cross section and high quantum efficiency, with sufficient solubility in the host to yield the concentrations shown on the upper axis of the figure. Within the upper left allowed region, the lines represent contours of constant numbers of reads. The achievable number of reads varies from 1 to greater than 10^4 ; again superior performance results from low cross sections and high quantum efficiencies. (η values greater than 0.1 are not allowed, because hole broadening would occur due to excessive photochemistry, and σ values less than 10^{-15} cm² would require prohibitively high densities of centers.)

The results in Figure 5 show that a new challenge exists for scientists in the field of PHB: find single-photon materials that have values of quantum efficiency and cross section that fall within the allowed region, as well as solubilities that allow concentrations shown along the top axis. One might look for hole-burning in partially allowed transitions, such as $n-\pi^*$ transitions of organic molecules and $d-f$ transitions of divalent rare earth systems. However, the parameter space of useful $\eta-\sigma$ values is somewhat small.

GATED PHB

One way around this problem would be to consider those materials that do not suffer from the intrinsic limitations of single-photon, monophotonic processes with no threshold. One such class of materials are those with two-step PHB mechanisms, called gated mechanisms in the second to the last entry in Table 2. Figure 6 shows the general idea of gating. The wavelength λ_1 excites a homogeneous packet within an inhomogeneously broadened line. If no external field is present, the center returns to the original ground state without forming a spectral hole. However, in the presence of λ_1 and some external field, the center undergoes the transformation leading to hole-burning. This is the origin of the term "gating": the external field acts as a gate on the hole-burning process. The hole may be detected using λ_1 alone, since hole detection is merely probing the ground state distribution of those centers that did not react to form the spectral hole. Since the external field is not present during the reading process, hole detection may then be nondestructive. In effect, gated mechanisms add a "threshold" to the writing process, which uncouples the reading and writing processes. The external field may be a second photon of a different wavelength (photon-gating[30]) or the gating could perhaps be achieved by any other external field, such as electric field, magnetic field, stress field, and the like.

Recent materials research at IBM has been devoted to a search for gated or two-color or photon-gated PHB mechanisms in inorganic as well as organic materials. In photon-gated PHB, two photons (of different wavelengths) are required for the photoinduced change leading to hole-burning (writing). Last year, photon gated PHB was observed for Sm^{+2} ions in BaClF crystals[31]. The mechanism is thought to involve a three-level process similar to that shown schematically in Figure 7. The first wavelength, λ_1 , excites the system from the ground state to an intermediate level. Extended irradiation at λ_1 produces essentially no hole production, but brief periods of simultaneous irradiation with λ_2 allows deep holes to be burned at λ_1 . The second photon is thought to excite the ion from level 2 to the conduction band or to an autoionizing level and the photoejected electron is subsequently trapped in the host matrix.

This material has a further exciting and unexpected property: a pattern of holes burned at low temperature persists even after cycling up to room temperature and back down to helium temperatures. Apparently, the electrons are trapped at sites with very high barriers, and the relaxation of strains upon cycling is small enough to prevent loss of the site selection. This discovery shows that materials exist that can relieve one of the most serious concerns with frequency domain optical storage: volatility of the stored data. Further experiments are in progress to understand this novel process, and the reader is urged to consult the references for more detail[31].

Moreover, two-color photon gated PHB has also been observed in an organic material composed of carbazole molecules in boric acid glasses[32]. This important result proves that gated mechanisms exist in organics as well as inorganics. In addition, one drawback of the inorganic material is the low absorption cross section, which prevents the achievement of usable optical densities in thin film samples. This problem is absent in the organic system, although the organic material requires near ultraviolet wavelengths for site-selection. The presumed mechanism is depicted schematically in Figure 8. Upon excitation in the singlet-singlet origin with $\lambda_1 = 335$ nm, the molecule undergoes intersystem crossing with a high yield to form triplets. From level 3 (the lowest triplet,

T₁), the molecules return to the original ground state if λ_2 is not present, and no hole is formed. However, in the presence of $\lambda_2=360-405$ nm, holes are formed at the singlet excitation wavelength, λ_1 . Excitation spectra of λ_2 and the product absorption spectrum suggest that the mechanism is photoionization of the molecule and trapping of the ejected electron in the boric acid glass matrix. The special property of boric acid glass in reducing the ionization potential of the guest is critically important for the two-step photoionization process: no two-color holes are formed if the host is changed to poly(methyl methacrylate), for example.

AREAS FOR FUTURE RESEARCH

These two new examples of gated spectral hole-burning have opened up a new class of materials for PHB, and considering the limitations on single-photon materials, the search for gated mechanisms should be an important area for future studies. Of course, the previous observations of gated PHB can only be regarded as proofs-of-principle, because the materials showing gating do not possess all the other required properties for frequency domain optical storage. Gated PHB should be observable in a variety of other systems that may offer improved properties. The search must now concentrate on finding the largest number of useful properties in one material active at diode laser wavelengths. Considering that 8-10 years of basic research was necessary on single-photon processes in order to attain the present level of understanding, gated processes deserve an equal amount of effort and attention. An generalized analysis of the reading and writing performance of gated PHB materials has recently been performed [33] that will aid in the continuing search for optimal mechanisms.

Nevertheless, single photon processes with η and σ values in the upper left corner of Figure 5 would satisfy many of the requirements for frequency domain optical storage applications. Since years of experience has already been gained in single-photon materials, and considering that gated PHB materials are extremely new, a parallel effort to find optimal single-photon processes would also be useful. For any material, the issue of erasability must be considered to see if a sufficient number of erase cycles can be achieved. Furthermore, the possible existence of deleterious heating effects must be ascertained to assure that reading and writing power levels are not so high that stored holes are broadened or erased. The future feasibility of a frequency domain optical storage system rests on the discovery of single-photon materials with the required values of cross section and quantum efficiency, or upon optimizing gated mechanisms for spectral hole-burning.

This work was supported in part by the Office of Naval Research.

1. G. Castro, D. Haarer, R. M. Macfarlane, and H. P. Trommsdorff, "Frequency selective optical data storage system," U. S. Patent No. 4,101,976, (1978).
2. G. C. Bjorklund, W. Lenth, and C. Ortiz, *Proc. Soc. Photo-Opt. Instr. Eng.* **298**, 107 (1981).
3. D. Haarer, *Proc. Soc. Photo-Opt. Instr. Engr.* **177**, 97 (1979).
4. A. R. Gutierrez, J. Friedrich, D. Haarer, and H. Wolfrum, *IBM J. Res. Devel.* **26**, 198 (1982), and references therein.
5. W. E. Moerner, *J. Molec. Elec.*, **1**, 55 (1985).
6. In this article, we will refer to the absorbing centers as "molecules", even though the centers could be color centers [7] or other types of defects.
7. R. M. Macfarlane, R. T. Harley, and R. M. Shelby, *Rad. Effects* **72**, 1 (1983), and references therein.
8. J. Friedrich and D. Haarer, *Angew. Chemie* **23**, 113 (1984), and references therein.
9. L. A. Rebane, A. A. Gorokhovskii, and J. V. Kikas, *Appl. Phys.* **B29**, 235-250 (1982).

10. G. J. Small, in Spectroscopy and Excitation Dynamics of Condensed Molecular Systems, V. M. Agranovitch and R. M. Hochstrasser, editors, (North-Holland, Amsterdam, 1983), pp. 515-554.
11. W. E. Moerner, A. J. Sievers, R. H. Silsbee, A. R. Chraplyvy, and D. K. Lambert, *Phys. Rev. Lett.* **49**, 398 (1982); W. E. Moerner, A. R. Chraplyvy, A. J. Sievers, and R. H. Silsbee, *Phys. Rev. B* **28**, 7244 (1983).
12. G. C. Bjorklund, M. D. Levenson, W. Lenth, and C. Ortiz, *Appl. Phys.* **B32**, 145 (1983).
13. P. Pokrowsky, W. Zapka, F. Chu, and G. C. Bjorklund, *Opt. Commun.* **44**, 175 (1983).
14. A. L. Huston and W. E. Moerner, *J. Opt. Soc. Am. B: Opt. Phys.* **1**, 349 (1984).
15. M. Romagnoli, M. D. Levenson, and G. C. Bjorklund, *Opt. Lett.* **8**, 635 (1983); M. Romagnoli, M. D. Levenson, and G. C. Bjorklund, *J. Opt. Soc. Am. B: Opt. Phys.* **1**, 571 (1984).
16. P. Pokrowsky, W. E. Moerner, F. Chu, and G. C. Bjorklund, *Opt. Lett.* **8**, 280 (1983).
17. P. Pokrowsky, W. E. Moerner, F. Chu, and G. C. Bjorklund, *Proc. Soc. Photo-Opt. Instr. Engr.* **382**, 202 (1983).
18. D. J. Bernays, *Proc. SPIE*, Vol. **498**, 175 (1984).
19. F. M. Schellenberg, W. E. Moerner, M. D. Levenson, G. C. Bjorklund, and D. J. Bernays (1984), Conference on Lasers and Electro-optics Technical Digest, June 19-22, 1984, Anaheim, California, paper ThI41.
20. B. H. Schechtman, G. C. Bjorklund, and W. E. Moerner, IBM Research Report # RJ4128, December 8, 1983.
21. M. Gehrtz, W. E. Moerner, and G. C. Bjorklund, IBM Research Report # RJ 4574, January 21, 1985.
22. W. E. Moerner, in Proceedings of the International Conference: Lasers '83, R. C. Powell, editor, (STS Press, McLean, VA, 1983), p. 489.
23. W. E. Moerner, F. M. Schellenberg, and G. C. Bjorklund, *Appl. Phys.* **B28**, 263 (1982); W. E. Moerner, P. Pokrowsky, F. M. Schellenberg, and G. C. Bjorklund (submitted to *Phys. Rev. B*).
24. H. W. H. Lee, A. L. Huston, M. Gehrtz, and W. E. Moerner, *Chem. Phys. Lett.* **114**, 491 (1985).
25. S. Völker and J. H. van der Waals, *Molec. Phys.* **32**, 1703 (1976); S. Völker and R. M. Macfarlane, *IBM J. Res. Devel.* **23**, 547 (1979).
26. W. Breinl, J. Friedrich, and D. Haarer, *Chem. Phys. Lett.* **106**, 487 (1984).
27. M. Romagnoli, W. E. Moerner, F. M. Schellenberg, M. D. Levenson, and G. C. Bjorklund, *J. Opt. Soc. Am. B: Optical Physics* **1**, 341 (1984).
28. W. E. Moerner and M. D. Levenson, *J. Opt. Soc. Amer. B: Optical Physics* **2**, 915 (1985).
29. W. E. Moerner, M. Gehrtz, and A. L. Huston, *J. Phys. Chem.* **88**, 6459 (1984).
30. D. M. Burland, F. Carmona, G. Castro, D. Haarer, and R. M. Macfarlane, *IBM Tech. Discl. Bull.* **21**, 3770 (1979).
31. A. Winnacker, R. M. Shelby, and R. M. Macfarlane, *Opt. Lett.* **10**, 350 (1985).
32. H. W. H. Lee, M. Gehrtz, E. Marinero, and W. E. Moerner, *Chem. Phys. Lett.* **118**, 611 (1985).
33. W. Lenth and W. E. Moerner, submitted to *Opt. Commun.* (1986).

Table 1. Engineering Requirements

Property	Material or Technique	Reference
Hole detection	FM spectroscopy, λ modulation, HUMPH, FREMPOLSPECT	[12] [13] [14] [15]
Reading and writing with diode lasers	current and temperature tuning	[16] [17]
Focus/servo in liquid He	Ronchi grating, dither	[18]
No crosstalk between adjacent spots	measured: R' in LiF	[19] [20]

Table 2. Material Requirements

Property	Material or Technique	Reference
$\Delta\nu_{\text{hole}} = 100\text{-}500$ MHz	color centers, H ₂ Pc-PE,...	[7] [22]
GaAlAs compatibility	R' in LiF(8330 Å) H ₂ Pc-PE in H ₂ SO ₄	[23] [24]
Reversible burning	H ₂ Pc, H ₂ P, ...	[9] [25]
Long hole lifetime at low temperatures	Quinizarin in glasses	[26]
Fast burning (≈ 30 ns/bit)	H ₂ Pc-PE	[27]
Fast burning, high SNR, fast reading, focused spot	difficult for single-photon mechanisms	[28]
Gated hole-burning mechanism	Sm ²⁺ -BaClF, carbazole in boric acid	[31] [32]
Room temperature cycling	Sm ²⁺ -BaClF	[31]

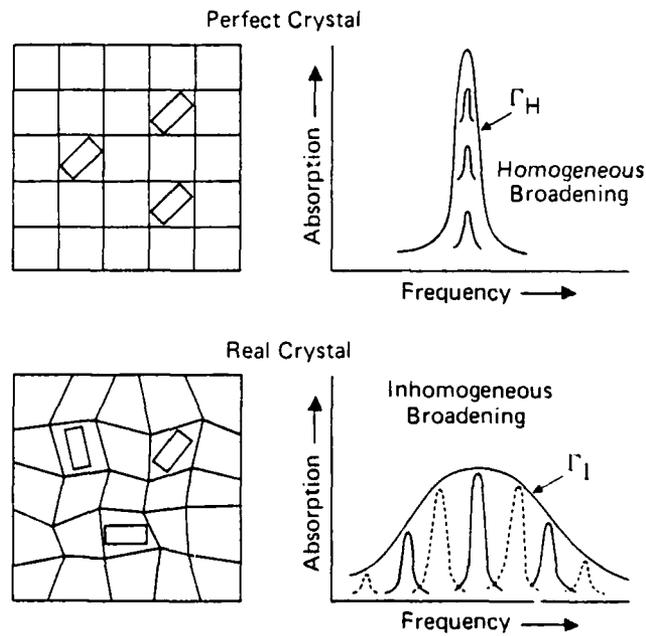


Fig. 1. (Upper half) Schematic of absorbers dispersed in a perfect crystal. At low temperatures, the absorption line is homogeneously broadened with width Γ_H . (Lower half) Illustration of one source of inhomogeneous broadening in real solid matrices. The distribution of local environments leads to a distribution of center frequencies of absorption. The resulting lineshape has width Γ_I .

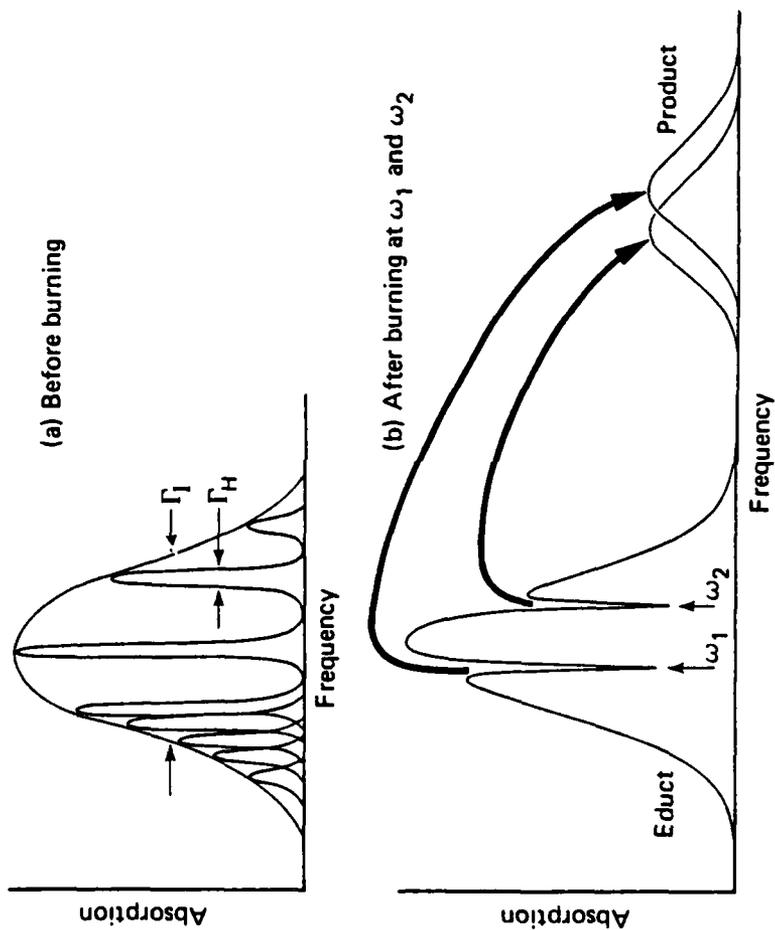


Fig. 2. (a) Schematic of an inhomogeneously broadened absorption line at low temperatures. (b) Illustration of the formation of a spectral hole due to laser irradiation at ω_1 and ω_2 .

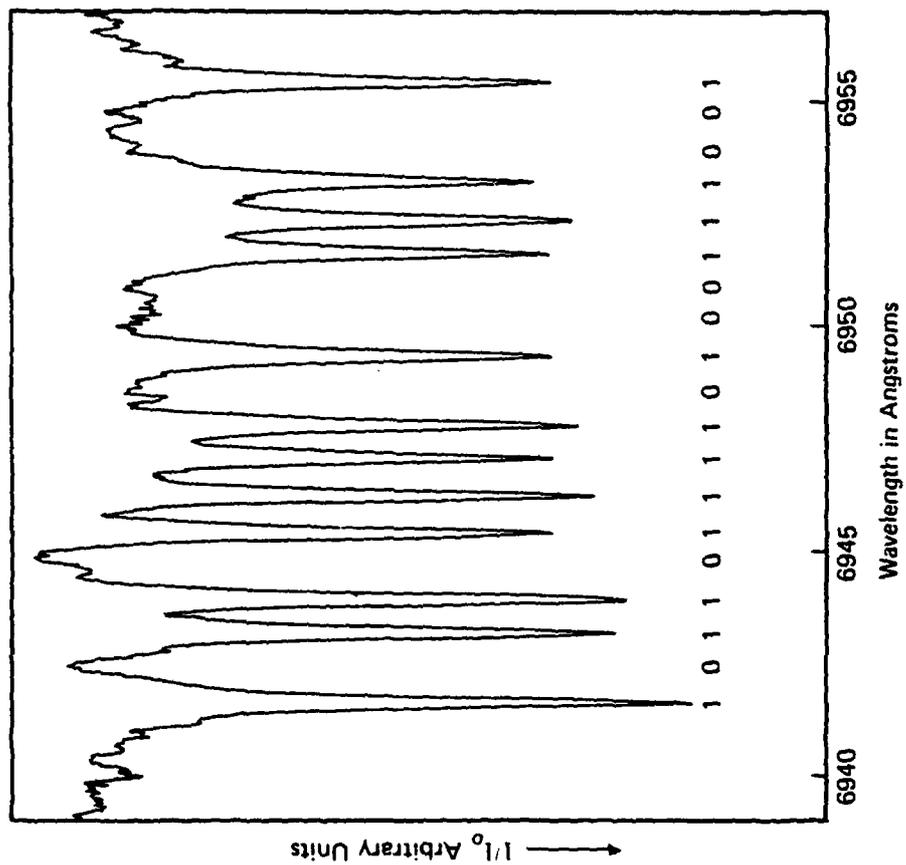


Fig. 3. Portion of the absorption spectrum for free-base phthalocyanine molecules in PMMA showing a sequence of holes burned in the absorption line (after Reference [4], by permission).

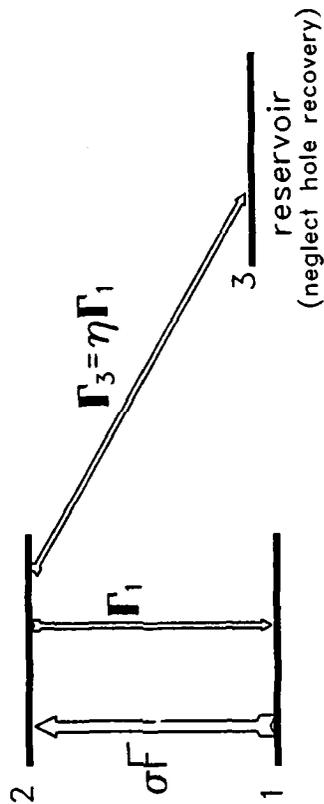


Fig. 4. Schematic energy level diagram for absorbing centers with a single-photon hole-burning mechanism. Level 1 is the ground state, level 2 is the excited state, and level 3 is a permanent reservoir ground state that schematically depicts the hole formation process. The various pumping and decay rates are defined in the text.

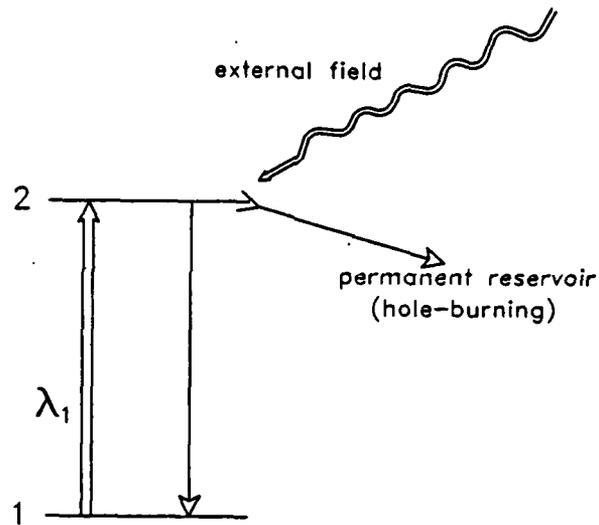


Fig. 5. Allowed region of efficiency η , cross section σ , and number density of centers at ω , in order for the first read to yield acceptable signal-to-noise ratio. M^* is the number of reads achievable for a given material. The contours in the upper left portion of the figure represent contours of constant M^* .

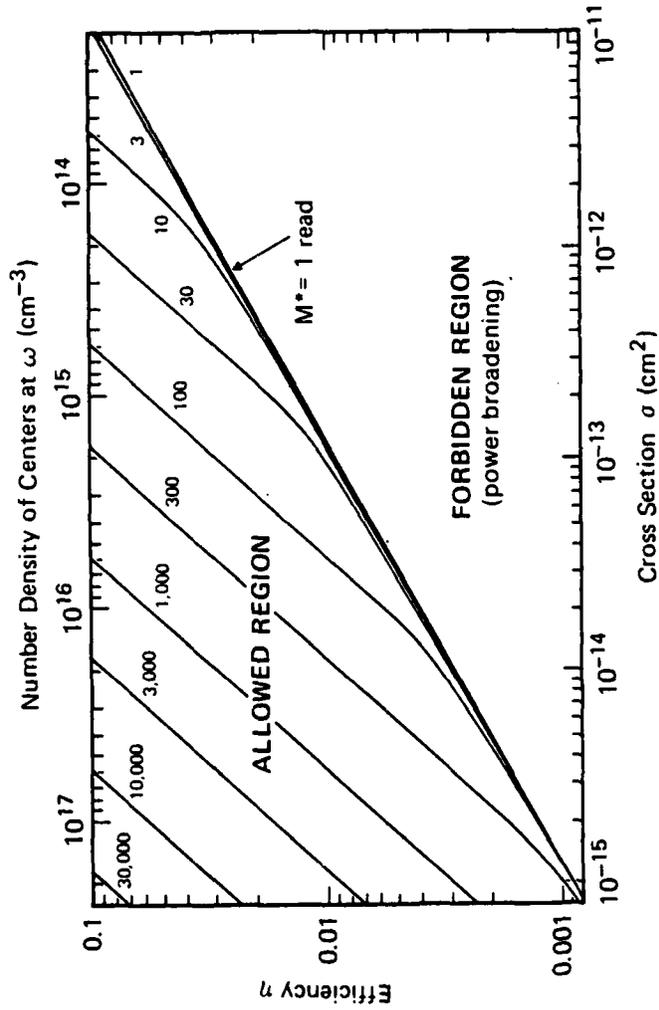


Fig. 6. Illustration of basic scheme for gated, two-step PHB.

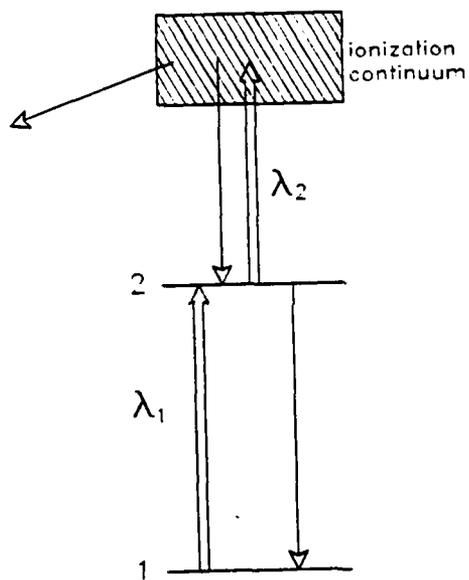


Fig. 7. Illustration of gated PHB for a three-level system.

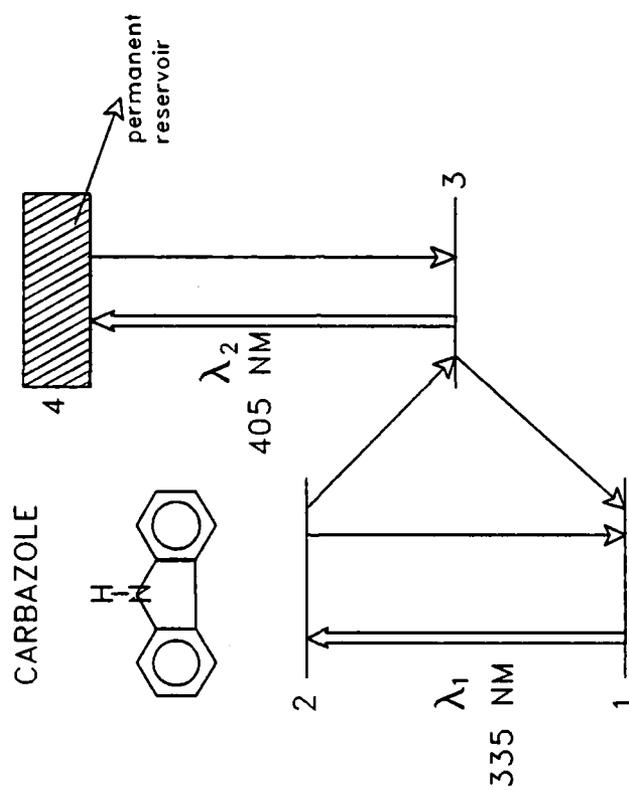


Fig. 8. Illustration of the four-level gated PHB mechanism for carbazole molecules in boric acid glass. Level 1 is the singlet ground state S_0 , level 2 is the singlet excited state S_1 , level 3 is the lowest triplet state T_1 , and the levels labeled 4 represent conduction band or autoionizing states that lead to photoionization.

TECHNICAL REPORT DISTRIBUTION LIST, GEN

	<u>No.</u> <u>Copies</u>		<u>No.</u> <u>Copies</u>
Office of Naval Research Attn: Code 1113 800 N. Quincy Street Arlington, Virginia 22217-5000	2	Dr. David Young Code 334 NORDA NSTL, Mississippi 39529	1
Dr. Bernard Douda Naval Weapons Support Center Code 50C Crane, Indiana 47522-5050	1	Naval Weapons Center Attn: Dr. Ron Atkins Chemistry Division China Lake, California 93555	1
Naval Civil Engineering Laboratory Attn: Dr. R. W. Drisko, Code L52 Port Hueneme, California 93401	1	Scientific Advisor Commandant of the Marine Corps Code RD-1 Washington, D.C. 20380	1
Defense Technical Information Center Building 5, Cameron Station Alexandria, Virginia 22314	12 high quality	U.S. Army Research Office Attn: CRD-AA-IP P.O. Box 12211 Research Triangle Park, NC 27709	1
DTNSRDC Attn: Dr. H. Singerman Applied Chemistry Division Annapolis, Maryland 21401	1	Mr. John Boyle Materials Branch Naval Ship Engineering Center Philadelphia, Pennsylvania 19112	1
Dr. William Tolles Superintendent Chemistry Division, Code 6100 Naval Research Laboratory Washington, D.C. 20375-5000	1	Naval Ocean Systems Center Attn: Dr. S. Yamamoto Marine Sciences Division San Diego, California 91232	1

965-IBM-80

END

12-86

DITIC